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February 9, 2004

To: Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

Fr: George O. Saile, Reg. No. 19,572

28 Davis Avenue

Poughkeepsie, N.Y. 12603

Subject:

Serial No. 10/718,865 11/21/03

Simon Chooi et al.

A METHOD TO CREATE A COPPER DIFFUSION DETERRENT INTERFACE

INFORMATION DISCLOSURE STATEMENT

Enclosed is Form PTO-1449, Information Disclosure Citation
In An Application.

The following Patents and/or Publications are submitted to comply with the duty of disclosure under CFR 1.97-1.99 and 37 CFR 1.56.

CERTIFICATE OF MAILING

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on February 19, 2004.

Stephen B. Ackerman, Reg.# 37761

Signature/Date

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- U.S. Patent 5,933,758 to Jain, "Method for Preventing Electroplating of Copper on an Exposed Surface at the Edge Exclusion of a Semiconductor Wafer", teaches a barrier layer over a dual damascene opening.
- U.S. Patent 5,693,563 to Teong, "Etch Stop for Copper Damascene Process", discusses dual barrier layers in a dual damascene process.
- U.S. Patent 5,451,542 to Ashby, "Surface Passivation Process of Compound Semiconductor Material Using UV Photosulfidation", teaches an S surface passivation process.

The following two U.S. Patents teach the use of a copper sulfide on copper wiring:

- 1) U.S. Patent 5,953,628 to Kawaguchi, "Method for Forming Wiring for a Semiconductor Device".
- 2) U.S. Patent 5,863,834 to Kawaguchi et al., "Semiconductor Device and Method of Manufacturing the Same."

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U.S. Patent 6,040,243 to Li et al., "Method to Form Copper Damascene Interconnects Using a Reverse Barrier Metal Scheme to Eliminate Copper Diffusion," discloses a method of fabricating damascene vias.

U.S. Patent 6,335,570 to Mori et al., "Semiconductor Device and Manufacturing Method Thereof," discloses a semiconductor device capable of preventing diffusion of a particle of copper or the like which forms a conductive layer without any increase in the number of manufacturing steps.

Sincerely,

Stephen B. Ackerman,

Reg. No. 37761

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ASSOCIATE POWER OF ATTORNEY

I hereby appoint Cheryl R. Figlin, registration number 39,562, as my associate attorney in this case. Her telephone number is (610) 821-0414.

Please continue to direct all correspondence in this case to the undersigned attorney.

Respectfully submitted,

Stephen B. Ackerman,

Principal attorney of record